

Microstructure Research: Cleanroom Linz

G. Bauer, H. Heinrich, H. Thim, G. Brunthaler

Institut für Halbleiter- und Festkörperphysik, and Institut für Mikroelektronik, Johannes Kepler Universität Linz, A-4040 Linz, Austria

The GMe supports the microstructure research in the cleanrooms of the Institut für Halbleiter- und Festkörperphysik and of the Institut für Mikroelektronik in Linz. In the field of high-frequency devices a fast frequency counter at 35 GHz for a distance sensor device was realized in 1999, capable of measuring the frequency with a 20 bit resolution in 120 microseconds. In the field of Si/SiGe devices, the activities were concentrated on the deposition of Si/SiGeC heterobipolar transistors on preprocessed wafers provided by an Austrian industrial partner. The structuring activities were concentrated on nanometer length Schottky gates. The optoelectronic activities were pursued for Er-doped Si diodes for light generation and by realizing vertical cavity surface emitting lasers for the 4 to 6 μm wavelength range. Magnetic structures were realized by depositing Fe on GaAs and ZnSe, and steps towards an in-situ optical process control for molecular beam epitaxial growth involving reflection difference spectroscopy were made. Semiconductor nanostructures like wires and dots, fabricated by self-assembled growth were investigated with respect to their elastic and optical properties.

The funding of the activities in the two cleanrooms at the University of Linz which are jointly used by three groups is of vital importance for our microstructure research activities. This basic funding allows for investigations which are made possible through additional funding coming from the FWF, FFF, the OeNB, as well as through cooperation with industrial groups as listed below.

In the following short presentations an overview is given on the achievements made in the cleanrooms in Linz in 1999. The basic equipment which is available in these clean rooms allows for MBE growth of Si-based heterostructures, of II-VI and IV-VI heterostructures, for the deposition of ferromagnetic layers like Fe on II-VI as well as III-V compounds, as well as for MOCVD growth of III-V compounds like GaAs/GaAlAs and GaAs/GaInAs. Apart from *in-situ* and *ex-situ* structural characterization, lateral patterning is made possible through equipment like optical, holographic, and electron beam lithography. Processing includes also facilities for the deposition on insulating as well as contact layers. In this respect, a major investment has been made: Equipment for the deposition of oxide and nitride layers has been purchased for the clean room of the semiconductor physics building which will be installed in 2000. Furthermore, through funds made available by the Ministry of Science and Traffic a transmission electron microscope has been ordered which will also be installed in the year 2000. This will greatly enhance our analytical possibilities for device oriented work.

Consequently, studies related to high frequency electronic and to optoelectronic devices can be performed which are described in the following.

For the section on HF-systems, a fast frequency counter at operating at 35 GHz, applied to a microwave distance sensor for short-range applications was realized. The main feature of this device is its capability to measure frequencies with a 20 bit resolution. It allows for system linearization of the oscillator characteristics.

Si-SiGe heterobipolar transistors are now widely introduced in the production for high speed bipolar and BiCMOS circuits, offering a speed advantage without sacrificing the compatibility to standard Si technologies. In Linz steps towards the optimization of the doping and composition profiles for the SiGeC HBT technology were made in a collaboration with Austria Microsystems (AMS), Unterpemstätten. Processed wafers provided by AMS were overgrown in Linz, and the essential conditions for the optimization of the layer sequence were studied.

In the field of lateral nanostructuring of Si/SiGe, work has been performed on selective Si and Si/SiGe epitaxy employing shadow masks. In particular, the lateral boundary between crystalline and polycrystalline Si areas was studied. It was shown that a defined undercut can be created thermally in a simple SiO₂ mask. This has led to the controlled deposition of Si/SiGe wire structures, which show excellent material quality as evidenced by their structural as well as by their optical (luminescence) properties.

Furthermore, work on growth instabilities found in Si homoepitaxy was pursued, extending the investigations to Si/SiGe in order to find out which role is played by the lattice strain due to the mismatch. In this respect, also studies were made towards a better understanding of the surface undulations which occur in lattice mismatched heteroepitaxy. The lateral and vertical ordering of self-organized structures has been studied in detail and the role of the anisotropy of the elastic properties for this ordering has been established quantitatively.

In the section on optoelectronics several contributions are incorporated into this report: The studies on electroluminescence from Si diodes by using Er doping were pursued, and in particular a mid-infrared vertical cavity surface emitting laser was realized, which has found international esteem. Work on reflectance difference spectroscopy was performed in order to allow for a real-time in-situ growth control in MBE as well as in MOCVD systems. In the framework of a European project, this system will be adapted for the process control of GaN in cooperation with partners from industry and from several universities.

Studies aimed towards the rapidly developing field of spintronics are being done: So far, growth studies have been performed by depositing Fe on GaAs and ZnSe, and by investigating the optical response of heterostructures containing manganese.

Project Information for 1999

Project Manager

Doz. Dr. Gerhard BRUNTHALER

Institut für Halbleiter- und Festkörperphysik, Johannes Kepler Universität Linz, A-4040 Linz, Austria

Project Group

Last Name	First Name	Status	Remarks
Bauer	Günther	University professor	
Heinrich	Helmuth	University professor	
Thim	Hartwig	University professor	
Schäffler	Friedrich	University professor	
Jantsch	Wolfgang	University professor	
Brunthaler	Gerhard	Associate professor	
Diskus	Christian	Associate professor	
Krenn	Heinz	Associate professor	
Palmeshofer	Leopold	Associate professor	
Springholz	Gunther	Associate professor	
Sitter	Helmut	Associate professor	
Heiss	Wolfgang	Assistant professor	
Kolmhofer	E.	Assistant professor	
Lübke	Kurt	Assistant professor	
Binder	Fritz	Technician	
Fuchs	Othmar	Technician	
Hinterreiter	Marion	Technician	
Kainz	Ursula	Technician	
Katzenmayer	Hans	Technician	
Rabeder	Klaus	Technician	
Wirtl	Elisabeth	Technician	
Stepikhova	Margarita	Guest	
Bierleutgeb	Karin	Ph.D. student	
Bonanni	Alberta	Ph.D. student	
Daniel	Anke	Ph.D. student	
Kocher	Gudrun	Ph.D. student	

Last Name	First Name	Status	Remarks
Montaigne-R.	Alberto	Ph.D. student	
Mühlberger	Michael	Ph.D. student	
Pinczolits	Michael	Ph.D. student	
Prechtl	Gerhard	Ph.D. student	
Raab	Anneliese	Ph.D. student	
Roch	Tomas	Ph.D. student	
Sandersfeld	Nils	Ph.D. student	
Schelling	Christoph	Ph.D. student	
Schwarzl	Thomas	Ph.D. student	
Seyringer	Heinz	Ph.D. student	
Stangl	Julian	Ph.D. student	
Wiesauer	Karin	Ph.D. student	
Zhuang	Yan	Ph.D. student	
Grillberger	C.	Diploma student	
Landsiedl	M.	Diploma student	
Lengauer	G.	Diploma student	
Raiser	S.	Diploma student	
Schraml	S.	Diploma student	

Publications in Reviewed Journals

1. M. Helm, W. Hilber, G. Strasser, R. De Meester, F.M. Peeters, A. Wacker: “Continuum Wannier-Stark ladders strongly coupled by Zener resonances in semiconductor superlattices”, *Physical Review Letters* **82**, 3120-3123 (1999).
2. A. Prinz, G. Brunthaler, Y. Ueta, G. Springholz, G. Bauer, G. Grabecki, T. Dietl: “Electron localization in $n\text{-Pb}_{1-x}\text{Eu}_x\text{Te}$ ”, *Physical Review B* **59**, 12983-12990 (1999).
3. M. Pinczolits, G. Springholz, G. Bauer: “Molecular beam epitaxy of highly faceted self-assembled IV-VI quantum dots with bimodal size distribution”, *Journal of Crystal Growth* **201/202**, 1126-1130 (1999).
4. G. Springholz, T. Schwarzl, W. Heiss, H. Seyringer, S. Lanzerstofer, H. Krenn: “MBE growth of highly efficient lead salt-based Bragg mirrors on BaF_2 (111) for the 4 – 6 μm wavelength region”, *Journal of Crystal Growth* **201/202**, 999 -1004 (1999).
5. V. Holy, J. Stangl, S. Zerlauth, G. Bauer, N. Darowski, D. Lübbert, U. Pietsch: “Lateral arrangement of self-assembled quantum dots in an SiGe/Se superlattice”, *Journal of Physics D (Applied Physics)* **32**, A234-A238 (1999).
6. J. Grim, V. Holy, J. Kubena, J. Stangl, A.A. Darhuber, S. Zerlauth, F. Schäffler, G. Bauer: “Diffuse x-ray reflectivity of strain-compensated $\text{Si}/\text{SiGe}/\text{SiC}$ multilayers”, *Journal of Physics D (Applied Physics)* **32**, A216-A219 (1999).

7. J. Grim, V. Holy, J. Kubena, A.A. Darhuber, G. Bauer, S. Zerlauth: “*X-ray reflection from self-organized interfaces in a SiGe/Si multilayer*”, Semiconductor Science and Technology **14**, 32-40 (1999).
8. V. Holy, G. Springholz, M. Pinczolits, G. Bauer: “*Strain induced vertical and lateral correlations in quantum dot superlattices*”, Physical Review Letters **83**, 356-359 (1999).
9. K. Herz, G. Bacher, A. Forchel, H. Straub, G. Brunthaler, W. Faschinger, G. Bauer, C. View: “*Recombination dynamics in dry-etched (Cd,Zn)Se/ZnSe nanostructures: Influence of exciton localization*”, Physical Review B **59**, 2888-2893 (1999).
10. O. Gauthier-Lafaye, F.H. Julien, S. Cabaret, J.-M. Lourtioz, G. Strasser, E. Gornik, M. Helm, P. Bois: “*High-power GaAs/AlGaAs quantum fountain unipolar laser emitting at 14.5 μm with 2.5% tunability*”, Applied Physics Letters **74**, 1537-1539 (1999).
11. Y. Zhuang, V. Holy, J. Stangl, A.A. Darhuber, P. Mikulik, S. Zerlauth, F. Schäffler, G. Bauer, N. Darowski, D. Lübbert, U. Pietsch: “*Strain relaxation in periodic arrays of Si/SiGe quantum wires determined by coplanar high resolution x-ray diffraction and grazing incidence diffraction*”, Journal of Physics D (Applied Physics) **32**, A224-A229 (1999).
12. J. Stangl, V. Holy, P. Mikulik, G. Bauer, I. Kegel, T.H. Metzger, O.G. Schmidt, C. Lange, K. Eberl: “*Self-assembled carbon-induced germanium quantum dots studied by grazing-incidence small-angle x-ray scattering*”, Applied Physics Letters **74**, 3785-3787 (1999).
13. Y. Zhuang, J. Stangl, A.A. Darhuber, G. Bauer, P. Mikulik, V. Holy, N. Darowski, U. Pietsch: “*X-ray diffraction from quantum wires and quantum dots*”, Journal of Materials Science: Materials in Electronics **10**, 215-221 (1999).
14. F. Schinagl, A. Bonanni, S. Holl, G. Pechtl, H. Krenn: “*Magnetic polarons in MnTe layers*”, Journal of Magnetism and Magnetic Materials **198-199**, 194-196 (1999).
15. T. Schwarzl, W. Heiss, G. Kocher-Oberlehner, G. Springholz: “*CH₄/H₂ plasma etching of IV-VI semiconductor nanostructures*”, Semiconductor Science and Technology **14**, L11-L14 (1999).
16. Stangl, V. Holy, A.A. Darhuber, P. Mikulik, G. Bauer, J. Zhu, K. Brunner, G. Abstreiter: “*High-resolution x-ray diffraction on self-organized step bunches of Si_{1-x}Ge_x grown on (113)-oriented Si*”, Journal of Physics D (Applied Physics) **32**, A71-A74 (1999).
17. C. Schelling, G. Springholz, F. Schäffler: “*Kinetic Growth Instabilities on Vicinal Si (001) Surfaces*”, Physical Review Letters **83**, 995-998 (1999).
18. M. Pinczolits, G. Springholz, G. Bauer: “*Evolution of hexagonal lateral ordering in strain-symmetrized PbSe/PbEuTe quantum-dot superlattices*”, Physical Review B **60**, 11524-11529 (1999).
19. G. Grabecki, J. Wrobel, T. Dietl, K. Byczuk, E. Papis, E. Kaminska, A. Piotrowska, G. Springholz, M. Pinczolits, G. Bauer: “*Quantum ballistic transport in constrictions of n-PbTe*”, Physical Review B **60**, R5133-R5136 (1999).

20. T. Schwarzl, W. Heiss, G. Springholz: "*Ultra-high-finesse IV-VI microcavities for the midinfrared*", Applied Physics Letters **75**, 1246-1248 (1999).
21. M. Helm: "*The basic physics of intersubband transitions*", in: "Intersubband Transitions in Quantumwells: Physics and device applications", Semiconductors and Semimetals Vol. **62**, eds. H.C. Liu and F. Capasso (Academic Press 1999), p. 1-99.
22. M. Helm: "*Infrared Semiconductor Sources*", in: "Long-wavelength infrared emitters based on quantum wells and superlattices", ed.: M. Helm (Gordon and Breach 1999) p.1.
23. W. Heiss, G. Prechtel, D. Stifter, H. Sitter, G. Springholz, T. Riemann, F. Bertram, D. Rudloff, J. Christen, G. Bley, U. Neukirch, J. Gutowski, J. Liu: "*Luminescence of ZnCdSe/ZnSe ridge quantum wires*", Applied Physics Letters **75**, 974-976 (1999).
24. A. Bonanni, G. Prechtel, W. Heiss, F. Schinagl, S. Holl, H. Krenn, H. Sitter, D. Stifter, K. Hingerl: "*Reflectance difference spectroscopy and magneto-optical analysis of digital magnetic heterostructures*", Journal of Vacuum Science Technology B **17**, 1722-1727 (1999).
25. M. Berti, D. De Salvador, A. V. Drigo, J. Stangl, F. Schäffler, S. Zerlauth, G. Bauer: "*Behaviour of metastable $Si_{1-y}C_y$ epilayers under 2MeV Alpha particles irradiation*", in: Lattice Mismatched Thin Films, ed. by E.A. Fitzgerald (The Minerals, Metals & Materials-Society 1999) p. 53-59.
26. M. Helm, W. Hilber, G. Strasser, R. DeMeester, F.M. Peeters: "*Minibands and Wannier-Stark ladders in semiconductor superlattices studied by infrared spectroscopy*", Brazilian Journal of Physics **29**, 652 (1999).
27. G. Strasser, L. Hvozdar, S. Gianordoli, K. Unterrainer, E. Gornik, P. Kruck, M. Helm: "*GaAs/AlGaAs quantum cascade intersubband and interminiband emitter*", Journal of Crystal Growth **201-202**, 919 (1999).
28. T. Schwarzl, G. Springholz, H. Seyringer, H. Krenn, S. Lanzerstorfer, W. Heiss: "*High-reflectivity lead-salt-based Bragg mirrors for the mid-infrared range*", IEEE Journal of Quantum Electronics **35**, 1753-1758 (1999).
29. G. Strasser, S. Gianordoli, L. Hvozdar, K. Unterrainer, E. Gronik, P. Kruck, M. Helm: "*GaAs/AlGaAs quantum cascade intersubband emitter*", Proc. 24th International Conf. on the Physics of Semiconductors, World Scientific 1999.
30. M. Schatzmayr, E. Wachmann, M. Mühlberger, C. Schelling, and F. Schäffler: "*A fully certified SiGe-BiCMOS process for ASICs and multiproduct wafers*", Proc. Int. Semicond. Dev. Res. Symp., Charlottesville, VA, Dec. 1999.
31. M. Helm, W. Hilber, G. Strasser, R. De Meester, F.M. Peeters, A. Wacker: "*Simultaneous investigation of vertical transport and intersubband absorption in a superlattice: Continuum Wannier-Stark ladders and next-nearest neighbor tunneling*", Physica B **272**, 194-197 (1999).
32. G. Springholz: "*Observation of large-scale surface undulations due to inhomogenous dislocation strain fields in lattice-mismatched epitaxial layers*", Applied Physics Letters **75**, 3099-3102 (1999).

33. G. Springholz, T. Schwarzl, W. Heiss, H. Seyringer, S. Lanzerstorfer, H. Krenn: “*MBE growth of highly efficient lead-salt-based Bragg mirrors on (111) BaF₂ for the 4-6 μm wavelength region*”, *J. Cryst. Growth* **201-202**, 999-1004 (1999).
34. W. Heiss, G. Prechtel, D. Stifter, G. Springholz, L. Toth: “*ZnCdSe/ZnSe quantum wires fabricated by selective molecular beam epitaxy on prepatterned GaAs substrates*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 97.
35. K. Wiesauer, G. Springholz: “*Fabrication of semiconductor nanostructures by Scanning Force Microscopy*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 171.
36. G. Springholz, T. Schwarzl, W. Heiss, H. Seyringer, S. Lanzerstorfer, H. Krenn: “*Fabrication of highly efficient mid-infrared Bragg mirrors from IV-VI semiconductors*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 71.
37. T. Schwarzl, W. Heiss, G. Kocher-Oberlehner, G. Springholz: “*CH₄/H₂ Plasma Etching of IV-VI Semiconductors*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 197.
38. M. Mühlberger, F. Schäffler: “*Carbon Co-Doping of Si_{1-x}Ge_x:B Layers: Suppression of Transient Enhanced Diffusion*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 167.
39. H. Seyringer, B. Fünfstück, F. Schäffler: “*Electron Beam Lithography of Nanostructures*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 201.
40. N. Sandersfeld, H. Seyringer, G. Steinbacher, L. Palmetshofer, S. Zerlauth, F. Schäffler: “*Modulation Doped Si/Si_{1-x}Ge_x-Field-Effect Transistors*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 189.
41. C. Schelling, G. Springholz, F. Schäffler: “*Growth Instabilities in Si Homoepitaxy*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 193.
42. J. Stangl, Y. Zhuang, G. Bauer, C. Rosenblad, H. von Känel: “*Fast Growth Method for the Fabrication of Modulation Doped Si/SiGe Field Effect Transistors*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 207.
43. Y. Zhuang, P. Mikulik, V. Holy, G. Bauer, R. Hammond, T.E. Whall, E.H.C. Parker: “*Si/SiGe Layers on Patterned Substrates for MODFET Applications*”, in: “*Current Developments of Microelectronics*”, ed. K. Riedling (Gesellschaft für Mikroelektronik, Wien 1999) p. 213.
44. C. Rosenblad, T. Graf, J. Stangl, C. Penn., G. Bauer, and H. von Känel: “*SiGe heteroepitaxy at high growth rates by a new plasma enhanced CVD process*”, *Proceedings of the 24th International Conference on the Physics of Semiconductors*, ed. D. Gershoni (World Scientific, Singapore 1999).

45. G. Grabecki, J. Wrobel, T. Dietl, K. Byczuk, E. Papis, E. Kaminska, A. Piotrowska, G. Springholz and G. Bauer: “*Ballistic quantum transport in n-PbTe*”, Proceedings of the 24th International Conference on the Physics of Semiconductors, ed. D. Gershoni (World Scientific, Singapore 1999).
46. A. Darhuber, V. Holy, J. Stangl, S. Zerlauth, G. Bauer, N. Darowski, D. Lübbert, and U. Pietsch: “*Strain and strain relaxation in SiGe dot multilayers embedded in Si*”, Proceedings of the 24th International Conference on the Physics of Semiconductors, ed. D. Gershoni (World Scientific, Singapore 1999)
47. C. Pidgeon, P. Findlay, B. N. Murdin, J. Langerak, C. Ciesla, J. Oswald, A. Homer, G. Springholz, and G. Bauer: “*Auger recombination dynamics of lead salts under ps free electron laser excitations*”, Proceedings of the 24th International Conference on the Physics of Semiconductors, ed. D. Gershoni (World Scientific, Singapore 1999).
48. J. Stangl, S. Zerlauth, F. Schäffler, G. Bauer, M. Berti, D. De Salvador, A. V. Drigo, and F. Romanato: “*Deviation of lattice parameters from Vegards rule in SiGeC epilayers*”, Proceedings of the 24th International Conference on the Physics of Semiconductors, ed. D. Gershoni (World Scientific, Singapore 1999).
49. A. Bonanni, D. Stifter, K. Hingerl, H. Seyringer, H. Sitter: “*Self-assembling Mn-based Nanostructures on CdTe*”, Appl. Phys. Lett. **74**, 3732 (1999)
50. D. Stifter, A. Bonanni, M. Garcia-Rocha, M. Schmid, K. Hingerl, H. Sitter: “*In Situ Reflectance Difference Spectroscopy: N-Plasma Doping Process of MBE-grown ZnTe Layers*”, J. Cryst. Growth **201/202**, 132 (1999)
51. A. Bonanni, D. Stifter, K. Hingerl, H. Seyringer, H. Sitter: “*In Situ Characterization of the Growth Dynamics in MBE of Mn-based II-VI Compounds: Self-organized Mn Structures on CdTe*”, J. Cryst. Growth **201**, 707 (1999)
52. M. Stepikhova, L. Palmetshofer, W. Jantsch, H.J. von Bardeleben, N. Gaponenko: “*μm Infrared Photoluminescence Phenomena in Er-doped Porous Silicon*”, Appl. Phys. Lett. **74** (4), 537-539 (1999)
53. W. Jantsch, S. Lanzerstorfer, L. Palmetshofer, M. Stepikhova, H. Preier: “*Different Er centres in Si and Their Use for Electroluminescent Devices*”, J. Luminescence **80**, 9-17 (1999)
54. D. Stifter, A. Bonanni, K. Hingerl, H. Sitter: “*Zerstörungsfreie Messung dünner Schichten mit polarisationsoptischen Methoden*”, Elektrotechnik u. Informationstechnik, 116. Jg., H. 5, p. 315 (1999)
55. D. Stifter, M. Schmid, K. Hingerl, A. Bonanni, M. Garcia-Rocha, H. Sitter: “*In Situ Reflectance Difference Spectroscopy of II-VI Compounds: A Real Time Study of N-Plasma Doping During MBE*”, J. Vac. Sci. and Technol. **B17**, 1697 (1999)
56. A. Bonanni, G. Prechtel, W. Heiß, F. Schinagl, S. Holl, H. Krenn, H. Sitter: “*Reflectance Difference Spectroscopy and Magneto-Optical Analysis of Digital Magnetic Heterostructures*”, J. Vac. Sci. and Technol. **B17**, 1722 (1999)
57. S. Lanzerstorfer, J.D. Pedarnig, R.A. Gunasekaran, D. Bäuerle, W. Jantsch: “*1.54 μm Emission of Pulsed-laser Deposited Er-doped Films on Si*”, J. Luminescence **80**, 353-356 (1999)

58. H. Sitter, T. Nguyen Manh: “*Pristine and Ba-Doped C60 Epilayers — Growth and Characterization*”, Cryst. Res. Technol. **34**, 605-614 (1999)
59. W. Heiß, G. Pechtl, D. Stifter, H. Sitter, G. Springholz, T. Riemann, F. Bertram, D. Rudloff, J. Christen, G. Bley, U. Neukirch, J. Gutowski, J. Liu: “*Luminescence of ZnCdSe/ZnSe Ridge Quantum Wires*”, Appl. Phys. Lett. **75** (7), 974-976 (1999)
60. A. Bonanni, K. Hingerl, H. Sitter, D. Stifter: “*Reflectance Difference Spectroscopy of Mn Intra-Ion Transitions in p-Doped Diluted Magnetic Semiconductors*”, Phys. Stat. Sol. (b) **215**, 47 (1999)
61. A. Bonanni, H. Seyringer, D. Stifter, K. Hingerl, H. Sitter: “*Self-Assembling Mn-Based Nanostructures*”, Proc. Seminar “Current Developments of Microelectronics”, ed. by K. Riedling, p. 81 (1999)
62. D. Papajova, H. Sitter: “*Simulation of Epitaxial Growth: A Comparison of Stochastic and Rate Equation Models*”, In: Research Trends, Current Topics in Crystal Growth Research Vol. 5, 55-89 (1999)
63. J. Franc, P. Hlidek, H. Sitter, E. Belas, A.L. Toth, L. Turjanska, P. Höschl: “*Photoluminescence of Deep Levels in (CdZn)Te Correlation with Diffusion Length Measurements*”, Proc. ICDS San Francisco (1999)
64. E. Belas, R. Gill, J. Franc, H. Sitter, A.L. Toth, P. Moravec, P. Höschl: “*Dynamics of Native Point Defects in H₂ Plasma-Etched Narrow Gap (HgCd)Te*”, Proc. ICDS San Francisco (1999)
65. M. Stepikhova, Z. Krasil'nik, W. Jantsch, L. Palmetshofer, J. v. Bardeleben: “*Er-Related Photoluminescence in Porous Silicon - Optically Active Er Centers*”, Proc. Russ. Acad. Sci., Ser. of Physics, Vol. 63, N 2, pp. 400-405 (1999)
66. Z. Wilamowski, W. Jantsch, N. Sandersfeld, F. Schäffler: “*Dipolar Field, Spin Relaxation, e-e Exchange and Spin Gap in Si/SiGe Quantum Wells*”, Ann. Phys. (Leipzig) **8**, 5, 507-510 (1999)
67. W. Jantsch, Z. Wilamowski, N. Sandersfeld, F. Schäffler: “*Determination of Potential Fluctuations in Modulation-Doped SiGe Quantum Wells from Conduction Electron Spin Resonance*”, Proc. ICDS-20 (1999)
68. W. Jantsch, S. Lanzerstorfer, L. Palmetshofer, M. Stepikhova, G. Kocher, H. Preier: “*On the Generation of Optically Active Er Centers in Si Light Emitting Diodes*”, Physica B **273-274**, 944-946 (1999)
69. N. Sandersfeld, W. Jantsch, Z. Wilamowski, F. Schäffler: “*ESR Investigations of Modulation-Doped Si/SiGe Quantum Wells*”, GADEST 99, ed. by H.G. Grimmeiss et al., in : Solid State Phenomena **69-70**, 191 (1999)
70. Kozanecki, H. Przybylinska, W. Jantsch, L. Palmetshofer: “*Room Temperature Photoluminescence Excitation Spectroscopy of Er³⁺ Ions in Er- and (Er³⁺Yb)-Doped SiO₂ Films*”, Appl. Phys. Lett. **75** (14), 2041 (1999)
71. W. Jantsch, S. Lanzerstorfer, M. Stepikhova, H. Preier, L. Palmetshofer: “*Status, Hopes and Limitations for the Si:Er-Based 1.54 μm Emitter*”, GADEST 99, ed. by H.G. Grimmeiss et al., in : Solid State Phenomena **69-70**, 53 (1999)
72. I.A. Karpovich, M.V. Stepikhova, W. Jantsch: “*Heteroepitaxial Passivation of GaAs Surfaces and Its Influence on Photosensitivity Spectra and Recombination*”

- Parameters of GaAs Epitaxial Layers and Semi-Insulating Materials*”, In: Semicond. and Insul. Mat. ed. By. Z. Lilienthal-Weber and C. Miner, IEEE Inc., p.63 (1999)
73. W. Jantsch, Z. Wilamowski, N. Sandersfeld, F. Schäffler: “*Conduction Electron Spin Resonance in Si/Si_{1-x}Ge_x Quantum Wells*”, Proc. Int. Conf. Phys. Semicond., Jerusalem 1998, ed. by D. Gershoni (World Scientific, Singapore 1999)
 74. S. Lanzerstorfer, W. Jantsch, M. Stepikhova, L. Palmetshofer, H. Preier: “*Which Type of Center is Responsible for the 1.54 μm Emission in Si:Er at 300 K*”, Proc. Int. Conf. Phys. Semicond., Jerusalem 1998, ed. by D. Gershoni (World Scientific, Singapore 1999)
 75. Kozanecki, W. Jantsch, M. Stepikhova, S. Lanzerstorfer, A. Henry, J.P. Bergmann: “*Spectroscopic Characterization of Er³⁺ Ions in 6H SiC*”, Proc. Int. Conf. Phys. Semicond., Jerusalem 1998, ed. by D. Gershoni (World Scientific, Singapore 1999)
 76. S. Lanzerstorfer, J.D. Pedarnig, R.A. Guansekar, D. Bäuerle, W. Jantsch
Photoluminescence at 1.5 μm Heavily Er-Doped Insulating Films on Si
In: Semicond. and Insulating Mat., ed. by Z. Lilienthal-Weber and C. Miner, IEEE Inc., p. 169 (1999)
 77. N.V. Gaponenko, A.V. Mydri, O.V. Sergeev, V.E. Borisenko, M. Stepikhova, L. Palmetshofer, W. Jantsch, J.C. Pivin, B. Hamilton, A.S. Baran, A.I. Rat’ko: “*On the Origin of 1.5 μm Luminescence in Porous Silicon Coated with Sol-Gel Derived Erbium Doped Fe₂O₃ Films*”, J. Luminescence **80**, 399-403 (1999)
 78. S. Lanzerstorfer, J.D. Pedarnig, R.A. Guansekar, D. Bäuerle, W. Jantsch: “*1.5 μm Emission of Pulsed-Laser Deposited Er-Doped Films on Si*”, J. Luminescence **80**, 353-356 (1999)
 79. T. Schwarzl, G. Springholz, H. Seyringer, H. Krenn, S. Lanzerstorfer, W. Heiß: “*High Reflectivity Lead Salt Based Bragg Mirrors for the Mid Infrared Range*”, IEEE J. Quantum Electronics **35**, 1753 (1999)
 80. G. Springholz, T. Schwarzl, W. Heiß, H. Seyringer, S. Lanzerstorfer, H. Krenn: “*MBE Growth of Highly Efficient Lead Salt Based Bragg Mirrors on BaF₂(111) for the 4-6 μm Wavelength Region*”, J. Cryst. Growth **201/202**, 999 (1999)
 81. H. Sitter, W. Heiss, K. Hingerl: “*Optical Characterization of Low Dimensional II-VI Compound Heterostructure*”, Proc. CLACSA, Havana 1999 (World Scientific)
 82. A. Yu. Andreev, B.A. Andreev, M.N. Drozdov, H. Ellmer, V.P. Kuznetsov, N.G. Kalugin, Z.F. Krasil’nik, Yu.A. Karov, L. Palmetshofer, K. Piplits, R.A. Rubtsova, M.N. Stepikhova, E.A. Uskova, V.B. Shmagin, H. Hutter: “*Electrical and Optical Properties of Silicon Doped by Er during Sublimational Molecular Beam Epitaxy*”, Proc. Russ. Acad. Sci., Ser. of Physics **63**, 392 (1999)
 83. A.Yu. Andreev, B.A. Andreev, M.N. Drozdov, Z.F. Krasil’nik, M.N. Stepikhova, V.B. Shmagin, V.P. Kuznetsov, R.A. Rubtsova, E.A. Uskova, Yu.A. Karpov, H. Ellmer, L. Palmetshofer, K. Piplits, H. Hutter: “*Optically Active Layers of Silicon Doped with Erbium during Sublimational Molecular Beam Epitaxy*”, Semicond. **33**, 131 (1999)

84. Yu. Suprun-Belevich, L. Palmeshofer, B.J. Sealy, N. Emerson: “*Mechanical Strain and Electrically Active Defects in Si Implanted with Ge⁺ Ions*”, *Semicond. Sci. Technol.* **14**, 565 (1999)
85. B.A. Andreev, A.Yu. Andreev, H. Ellmer, H. Hutter, Z.F. Krasil’nik, V.P. Kuznetsov, S. Lanzerstorfer, L. Palmeshofer, K. Piplits, R.A. Rubtsova, N.S. Sokolov, V.B. Shmagin, M.V. Stepikhova, E.A. Uskova: “*Optical Er-Doping of Si during Sublimational Molecular Beam Epitaxy*”, *J.Cryst. Growth* **201/202**, 534 (1999)

Submitted / in print:

1. G. Springholz, J. Stangl, M. Pinczolits, V. Holy, P. Mikulik, P. Mayer, K. Wiesauer, G. Bauer, D. Smilgies, H.H. Kang, L. Salamanca-Riba: “Nearly perfect 3D ordering in IV-VI quantum dot superlattices with ABCABC... vertical stacking sequence”, *Physica E*, in print.
2. G. Springholz, M. Pinczolits, V. Holy, P. Mayer, K. Wiesauer, T. Roch, G. Bauer: “Self-organized growth of three-dimensional IV-VI semiconductor quantum dot crystals with fcc-like vertical stacking and tunable lattice constant”, *Surface Science*, in print.
3. J. Stangl, V. Holy, J. Grim, G. Bauer, J. Zhu, K. Brunner, G. Abstreiter, O. Kienzle, F. Ernst: “Structural investigation of Si/SiGe superlattices on vicinal (113) oriented Si”, *Thin Solid Films* 351 (1999), in print.
4. V. Holy, G. Springholz, M. Pinczolits, G. Bauer: “Lateral ordering in quantum dot PbSe/PbEuTe superlattices”, *Proceedings of the 9th International Conference on Narrow Gap Semiconductors*, ed. M. von Ortenberg (Berlin 1999), in print.
5. V. Holy, J. Stangl, G. Springholz, M. Pinczolits, G. Bauer, I. Kegel, T.H. Metzger: “Lateral and vertical ordering of self-assembled PbSe quantum dots studied by high-resolution x-ray diffraction”, *Physica B*, in print.
6. D. De Salvador, M. Petrovich, M. Berti, F. Romanato, E. Napolitani, A. Drigo, J. Stangl, S. Zerlauth, M. Mühlberger, F. Schäffler, G. Bauer, P.C. Kelires: “Lattice parameter of Si_{1-x-y}GexCy alloys”, *Physical Review B*, in print.
7. G. Springholz: “Molecular Beam Epitaxy of IV-VI Heterostructures and Superlattices”, in: “Lead Chalcogenides: Physics and Applications”, eds. D. Khoklov, Gordon and Breach, in print.
8. M. Helm, W. Hilber, G. Strasser, R. DeMeester, F.M. Peeters, A. Wacker: “Interminiband spectroscopy of biased superlattices”, *Physica E*, in print.
9. N. Sandersfeld, W. Jantsch, Z. Wilamowski, F. Schäffler: “ESR investigations of modulation-doped Si/SiGe quantum wells”, *Thin Solid Films*, in print.
10. F. Schäffler: “Silicon-Germanium”, in: “Properties of Advanced Semiconductor Materials”, eds. M.E. Levinshstein, S.L. Rumyantsev, M.S. Shur, John Wiley & Sons, New York 1999, in print.
11. M. Mühlberger, C. Schelling, N. Sandersfeld, H. Seyringer, F. Schäffler: “High-Speed Transport in Si/Si_{1-x-y}GexCy Heterostructures”, *Thin Solid Films*, in print.
12. T. Schwarzl, W. Heiss, G. Springholz: “High finesse IV-VI microcavities for the mid infrared”, *Physica E*, in print.

13. W. Heiss, G. Pechtl, D. Stifter, H. Sitter, G. Springholz, T. Riemann, F. Bertram, D. Rudloff, J. Christen, G. Bley, U. Neukirch, J. Gutowski, J. Liu: "Luminescence of ZnCdSe/ZnSe ridge quantum wires", *Physica E*, in print.
14. C. Rosenblad, J. Stangl, E. Müller, G. Bauer, H. von Känel: "Strain relaxation of SiGe graded buffers grown at very high rates", EMRS 1999, in print.
15. H. Beyer, J. Nurnus, H. Böttner, A. Lambrecht, G. Springholz, G. Bauer: "MBE and Thermoelectric Properties of PbTe/Pb_{1-x}Sr_xTe MQW Structures", Proc. 9th International Conference on Narrow Gap Semiconductors, 1999, in print.
16. W. Heiss, T. Schwarzl, G. Springholz: "Lead-salt based Bragg mirrors and microcavities for the mid-infrared", Proc. 9th International Conference on Narrow Gap Semiconductors, 1999, in print.
17. T. Schwarzl, W. Heiss, G. Springholz, M. Aigle, H. Pascher: "6 μm vertical cavity surface emitting laser based on IV-VI semiconductor compounds", *Electronics Letters*, in print.
18. G. Strasser, S. Gianordoli, L. Hvozdar, W. Schrenk, K. Unterrainer, E. Gornik, M. Helm: "Intersubband and interminiband GaAs/AlGaAs quantum cascade lasers at 10 microns", *Physica E*, in print.
19. F. Schäffler: "Electron and Hole Mobilities", SiGe EMIS Data Review, ed. E. Kasper, in print.
20. Y. Zhuang, C. Schelling, T. Roch, A. Daniel, F. Schäffler, G. Bauer, J. Grenzer, U. Pietsch, S. Senz: "Investigation of inhomogeneous in-plane strain relaxation in Si/SiGe quantum wires by high resolution x-ray diffraction", *Mat. Res. Soc. Symp. Proc.*, in print.
21. C. Schelling, G. Springholz, F. Schäffler: "New kinetic growth instabilities in Si (001) homoepitaxy", *Thin Solid Films*, submitted.
22. C. Penn, G. Bauer, F. Schäffler, S. Glutsch: "Band Ordering of the Pseudomorphic Si_{1-x}Gex/Si Heterostructure: The Fundamental Role of Excitons", *Thin Solid Films*, in print.
23. Y. Zhuang, C. Schelling, J. Stangl, C. Penn, S. Senz, F. Schäffler, A. Daniel, and U. Pietsch, G. Bauer: "Structural and optical properties of Si/Si_{1-x}Gex wires", *Thin Solid Films*, in print.
24. Y. Zhuang, U. Pietsch, J. Stangl, V. Holy, N. Darowski, J. Grenzer, S. Zerlauth, F. Schäffler, G. Bauer: "In-plane strain and shape analysis of Si/SiGe nanostructures by grazing incidence diffraction", *Physica B, XSNS 6*, Holland, in print.
25. C. Penn, F. Schäffler, G. Bauer, P. C. M. Christianen, J. C. Maan, and S. Glutsch: "Magnetoluminescence Investigations on Si/Si_{0.76}Ge_{0.24} Quantum Wells", *Physical Review B*, submitted.
26. G. Springholz, M. Pinczolit, P. Mayer, V. Holy, G. Bauer, H. H. Khang, and L. Salamanca-Riba: "Tuning of lateral and vertical correlations in self-organized PbSe/PbEuTe quantum dot superlattices", *Physical Review Letters*, in print.
27. G. Springholz, T. Schwarzl, M. Aigle, H. Pascher, and W. Heiss: "4.8 μm vertical emitting PbTe quantum well lasers based on high finesse EuTe/PbEuTe microcavities", *Applied Physics Letters*, submitted.

28. H. H. Kang, L. Salamanca-Riba, M. Pinczolits, G. Springholz, V. Holy, and G. Bauer: "TEM investigation of self-organized PbSe quantum dots as a function of spacer layer thickness and growth temperature", Proceedings of the Materials Research Society, submitted
29. D. Papajova, M. Vesely, H. Sitter: "A Study of the Surface Roughness Using a Temperature Activated Rate Equation Model", Mat. Sci. in Semicond. Processing
30. L. Bocanek, B. Handlirova, J. Humlicek, T. Nguyen Manh, H. Sitter: "Temperature Dependence of Optical Spectra of C60 Thin Films", Fullerenes Sci. and Technol.
31. P. Hanzalek, I. Ohlidal, H. Sitter: "Reflectance of Thin Films with Non-Uniform Thickness", J. Opt. Eng.
32. D. Ferraud, J. Cibert, C. Bourgognon, S. Tatarenko, A. Wasiela, G. Fishman, A. Bonanni, H. Sitter, S. Kolesnik, J. Jaroszynski, T. Dietl: "Carrier Induced Ferromagnetic Interaction in p-Doped ZnMnTe Epilayers", J. Cryst. Growth
33. A. Bonanni, K. Hingerl, W. Hilber, H. Sitter, D. Stifter: "In Situ Reflectance Difference Spectroscopy of Intra-Mn Transitions in Highly N-Doped II-VI Diluted Magnetic Semiconductors", J. Cryst. Growth
34. A. Bonanni, K. Hingerl, H. Sitter, D. Stifter: "Reflectance Difference Spectroscopy: A Powerful Tool for in Situ Investigations of II-VI Compounds with Mn", Thin Solid Films
35. N. Sandersfeld, W. Jantsch, Z. Wilamowski, F. Schäffler: "ESR Investigations of Modulation-Doped Si/SiGe Quantum Wells", IJC-Si, Japan 1999
36. M. V. Stepikhova, B.A. Andreev, V.B. Shmagin, Z.F. Krasil'nik, V.P. Kuznetsov, V.G. Shengurov, S.P. Svetlov, W. Jantsch, L. Palmetshofer, F. Schäffler, H. Ellmer: "Peculiarities and Advantages of Optically Active Si:Er and Si_{1-x}Gex Layers Grown by the Sublimation MBE Method", IJC-Si, Japan 1999
37. Z. Wilamowski, W. Jantsch, N. Sandersfeld, F. Schäffler: "Spin Properties of the Two-Dimensional Electron Gas", Physica B
38. W. Jantsch, Z. Wilamowski, N. Sandersfeld, F. Schäffler: "Electric and Magnetic Field Fluctuations in Modulation-Doped Si/SiGe Quantum Wells", Physica E
39. G. Springholz, T. Schwarzl, M. Aigle, H. Pascher, W. Heiss: "4.8 μm Vertical Emitting PbTe Quantum Well Lasers Based on High Finesse EuTe/Pb_{1-x}EuxTe Microcavities", Appl. Phys. Letters
40. T. Schwarzl, W. Heiss, G. Springholz, M. Aigle, H. Pascher: "6 μm Vertical Cavity Surface Emitting Lasers Based on IV-VI Semiconductor Compounds", Electronic Letters
41. G. Prechtl, W. Heiss, S. Mackowski, A. Bonanni, G. Karczewski, H. Sitter, W. Jantsch: "Single Antiferromagnetic MnTe (Sub)monolayers in CdTe/CdMgTe Quantum Wells", Semicond. Sci. and Technol.
42. T. Schwarzl, W. Heiss, G. Springholz: "High Finesse Mid Infrared Microcavities Based on Lead Salts", Physica E
43. K. Bierleutgeb, H. Sitter, H. Krenn, H. Seyringer: "A Comparative Study of Iron Films on II-VI and III-V Semiconductors", Proc. SLATES, Catargena 1999, Phys. stat. sol.

44. K. Hingerl, W. Hilber, R.E. Balderas-Navarro, A. Bonanni, H. Sitter, D. Stifter: "Surface Stress-Induced Optical Bulk Anisotropies", Phys. Rev. Lett.
45. Yu.P. Rakovich, A.G. Rolo, M.V. Stepikhova, M.I. Vasilevskiy, M.J.M. Gomes, M.V. Artemyev, W. Jantsch, W. Heiss, G. Prechtl: "Absorption and Photoluminescence Study of CdS Quantum Dots: The Role of Host Matrix and Nanocrystal Size and Density", Proc. MRS Spring Meeting 1999
46. W. Heiss, T. Schwarzl, G. Springholz: "Lead Salt Based Bragg Mirrors and Microcavities for the Mid Infrared", World Scientific

Presentations

Invited Talks:

1. G. Bauer: "Magnetic Semiconductor Superlattices", 9th Brazilian Workshop on Semiconductor Physics, Belo Horizonte, Brasilien, Feb. 1999.
2. M. Helm: "Minibands and Wannier-Stark ladders in semiconductor superlattices studied by infrared spectroscopy", 9th Brazilian Workshop on Semiconductor Physics, Belo Horizonte, Feb. 1999.
3. W. Heiss, T. Schwarzl, G. Springholz: "Lead Salt based Bragg Mirrors and Microcavities for the Mid-Infrared", 9th International Conference on Narrow Gap Semiconductors, Berlin, 27.9.-1.10. 1999.
4. V. Holy, G. Springholz, M. Pinczolits, G. Bauer: "Lateral Ordering in Quantum Dot PbSe/PbEuTe Superlattices", 9th International Conference on Narrow Gap Semiconductors, Berlin, 27.9.-1.10, 1999.
5. F. Schäffler: "High-Speed Transport in Si/SiGeC Heterostructures", Int. Joint Conference on Si Epitaxy and Heterostructures, Zao, Mijagi, Japan, Sept. 1999.
6. F. Schäffler: "Application of Silicon-Based Heterostructures in Microelectronics", Semicond. Dev. Res. Symp., Charlottesville VA, USA, Dec. 1999.
7. G. Springholz, M. Pinczolits, V. Holy, G. Bauer: "Self-organized growth of three-dimensional quantum dot crystals with fcc-like vertical stacking and tunable lattice constant", 18th European Conference of Surface Science, 21. - 24.9. 1999, Vienna, Austria.
8. G. Springholz, M. Pinczolits, V. Holy, G. Bauer: "Self-organized growth of semiconductors quantum dot crystals", Annual Meeting of the Austrian Physical Society, 20. - 25.9. 1999, Innsbruck, Austria.
9. G. Springholz: "Fabrication of Semiconductor Nanostructures and their Characterization by High Resolution X-ray Diffraction Techniques", 28th International School on Physics of Semiconducting Compounds, 6.-11.6.1999, Jaszowiec, Poland.
10. J. Stangl, V. Holy, G. Springholz, M. Pinczolits, P. Mikulik, G. Bauer: "Vertical and Lateral Arrangement in Dot Superlattices", Spring Meeting of the Materials Research Society, San Fransisco, USS, 5.-9. April 1999.
11. M. Helm: "Infrarotspektroskopie von Halbleitern", Heraeus-Ferienkurs "Festkörperspektroskopie", TU Dresden, BRD, 6.10. 1999.

12. F.Schäffler: "Silicon-Based Heterostructures for High-Speed Device Applications", Electronic Materials and Devices Seminar, Princeton NJ, USA, Dec. 1999.
13. G. Springholz: "Molecular Beam Epitaxy and in situ Reflection High-Energy Electron Diffraction Growth Studies of IV-VI Semiconductor Heterostructures", Fraunhofer Institut für physikalische Meßtechnik, 23.2.1999, Freiburg, Germany.
14. M. Helm: "Mid-infrared detectors and lasers based on intersubband transitions in quantum wells", Institute of Industrial Science, Tokyo University (Roppongi), Tokyo, Japan, 2.8.1999.
15. M. Helm: "Interminiband spectroscopy of semiconductor superlattices", Institute of Industrial Science, Tokyo University (Roppongi), Tokyo, Japan, 29.6.1999.
16. M. Helm: "Minibands and Wannier-Stark ladders in superlattices studied by infrared spectroscopy", Dept. of Basic Science, Tokyo University (Komaba), Tokyo, Japan, 25.6.1999.
17. M. Helm: "Minibands and Wannier-Stark ladders in superlattices studied by infrared spectroscopy", RIEC, Tohoku University, Sendai, Japan, 23.6.1999.
18. M. Helm: "Minibands and Wannier-Stark-ladders in semiconductor superlattices studied by infrared spectroscopy", Institut für Festkörperelektronik, TU Wien, 17.5.1999.
19. H. Sitter, K. Hingerl, W. Heiß: "Optical Characterization of Low Dimensional II-VI Compound Heterostructures", IX Latin American Congress on Surface Science and its Applications, Havana, July 1999
20. K. Bierleutgeb, H. Sitter, H. Krenn, H. Seyringer: "A Comparative Study of Iron Films on II-VI and III-V Semiconductors", IX Latin American Congress on Surface Science and its Applications, Havana, July 1999
21. W. Heiss, T. Schwarzl, G. Springholz: "Lead Salt Based Bragg Mirrors and Microcavities for the Mid Infrared", 9th Int. Conf. On Narrow Gap Semiconductors, Berlin, Sept.-Oct. 1999
22. W. Jantsch, S. Lanzerstorfer, M. Stepikhova, H. Preier, L. Palmetshofer: "Status, Hopes and Limitations for the Si:Er-Based 1.54 μm Emitter", GADEST 99, Höör, Schweden, Sept. 1999

Conference presentations (talks and posters):

1. G. Springholz, T. Schwarzl, W. Heiß, H. Seyringer, S. Lanzerstorfer and H. Krenn: "*Fabrication of highly efficient mid-infrared Bragg mirrors from IV-VI semiconductors*", Current Topics in Microelectronics, 3.3. - 6.3.1999, Bad Hofgastein, Austria.
2. K. Wiesauer and G. Springholz: "*Fabrication of Semiconductor Nanostructures by Scanning Force Microscopy*", Current Topics in Microelectronics, 3.3. - 6.3.1999, Bad Hofgastein, Austria.
3. M. Pinczolits, G. Springholz, V. Holy and G. Bauer: "*Nearly perfect 3D ordering in IV-VI quantum dot superlattices*", Gordon Research Conference on Thin Films and Crystal Growth Mechanisms, 20.6. - 25.6.1999, Plymouth, NH, USA.

4. T. Schwarzl, W. Heiss and G. Springholz: “*High finesse IV-VI microcavities for the mid infrared*”, International Conference on Modulated Semiconductor Structures, 12.7 - 16.7.1999, Fukuoka, Japan.
5. G. Springholz, M. Pinczolits, V. Holy, G. Bauer, H. H. Khang, L. Salamanca-Riba: “*Nearly perfect three dimensional ordering in IV-VI quantum dot superlattices with ABCABC... vertical stacking sequence*”, International Conference on Modulated Semiconductor Structures, 12.7 - 16.7.1999, Fukuoka, Japan.
6. G. Springholz, M. Pinczolits, V. Holy, P. Mayer, G. Bauer, H. H. Kang and L. Salamanca-Riba: “*Three dimensional ordering in PbSe/PbEuTe quantum dotsuperlattices with ABCABC...vertical stacking sequence*”, 9th International Conference on Narrow Gap Semiconductors, Berlin, 27.9.-1.10.1999.
7. T. Schwarzl, W. Heiss and G. Springholz: “*High Finesse Lead Salt Microcavities for the 4-7 μ m Spectral Region*”, MIOMD, Aachen, 17.9.-20.9., 1999.
8. G. Springholz, M. Pinczolits, V. Holy, G. Bauer, H. H. Kang, L. Salamanca-Riba: “*Vertical and lateral correlations in self-organized quantum dot superlattices*”, Fall Meeting of the Materials Research Society, 28.11. - 3.12.1999, Boston, USA.
9. W. Heiss, G. Prechtel, D. Stifter, H. Sitter, G. Springholz, L. Toth (poster): “*ZnCdSe/ZnSe Quantum Wires Fabricated by Selective Molecular Beam Epitaxy on Prepatterned GaAs Substrates*”: Current Topics in Microelectronics, 3.3. - 6.3.1999, Bad Hofgastein, Austria.
10. M. Pinczolits, G. Springholz, V. Holy and G. Bauer (poster): “*Molecular beam epitaxy of quantum dot crystals*”, Current Topics in Microelectronics, 3.3. - 6.3.1999, Bad Hofgastein, Austria.
11. G. Springholz and K. Wiesauer (poster): “*Depth resolution for scanning tunneling microscopy imaging of misfit dislocations in heteroepitaxial layers and multilayers*”, Gordon Research Conference on Thin Films and Crystal Growth Mechanisms, 20.6. - 25.6.1999, Plymouth, NH, USA.
12. W. Heiss, G. Prechtel, D. Stifter, H. Sitter, G. Springholz, T. Riemann, F. Bertram, D. Rudloff, J. Christen, G. Bley, U. Neukirch, J. Gutowski and J. Liu (poster): “*Luminescence of ZnCdSe/ZnSe ridge quantum wires*”, International Conference on Modulated Semiconductor Structures, 12.7 - 16.7.1999, Fukuoka, Japan.
13. M. Pinczolits, G. Springholz, V. Holy and G. Bauer (poster): “*Self-organized growth and hexagonal lateral ordering in PbSe/PbEuTe quantum dot superlattices*”, 18th European Conference on Surface Science, 21.-24.9.1999, Vienna, Austria.
14. H. H. Kang, L. Salamanca-Riba, G. Springholz, M. Pinczolits and G. Bauer (poster): “*Transmission electron microscopy investigations of self-organized PbSe/PbEuTe quantum dot superlattices*”, Fall Meeting of the Materials Research Society, 28.11. - 3.12.1999, Boston, USA.
15. K. Bierleutgeb, H. Sitter, H. Krenn and H. Seyringer: “*A comparative Study of Iron Films on II-VI- and III-V-semiconductors*”, 15th Latinamerican Symposium on Solid State Physics, Cartagena de Indias, Colombia, Nov. 1999.
16. C.Penn, S.Glutsch, G.Bauer and F.Schäffler: “*Band Ordering of the Pseudomorphic Si_{1-x}Ge_x/Si Heterostructure: The Fundamental Role of Excitons*”, Int. Joint Conf. Si, Zao, Miyagi, Japan, Sep. 1999

17. C. Penn, P.C.M. Christianen, F. Schäffler, J.C. Maan, G. Bauer: “*Type II band alignment and exciton wave-functions in Si/Si_{1-x}Ge_x quantum wells*”, 9th International Conference on Modulated Semiconductor Structures (MSS9), July 12-16, 1999, Fukuoka, Japan.
18. N.Sandersfeld, W.Jantsch, Z.Wilamowski, F.Schäffler: “*ESR Investigations of Modulation-Doped Si/SiGe Quantum Wells*”, Int. Joint Conf. Si, Zao, Miyagi, Japan, Sep. 1999
19. Y.Zhuang, C.Schelling, J.Stangl, S.Senz, F.Schäffler, A.Daniel, U.Pietsch, G.Bauer: “*Structural and Optical Properties of Si/Si_{1-x}Ge_x Wires*”, Int. Joint Conf. Si, Zao, Miyagi, Japan, Sep. 1999
20. C.Schelling, G.Springholz, F.Schäffler: “*New Kinetic Growth Instabilities in Si(001) Homoepitaxy*”, Int. Joint Conf. Si, Zao, Miyagi, Japan, Sep. 1999
21. M.Schatzmayr, E.Wachmann, M.Mühlberger, C.Schelling, F.Schäffler: “*A Fully Certified SiGe-BiCMOS Process for ASICs and Multiproduct Wafers*”, Semic. Dev. Res. Symp., Charlottesville VA, USA, Dec. 1999
22. Y. Zhuang, U. Pietsch, J. Stangl, N. Darowski, T. Roch, V. Holy, G. Bauer, S. Zerlauth, F. Schäffler: “*Investigation of inhomogenous strain relaxation in dry-etched SiGe/Si quantum wires using GID*”, MRS 1999, Boston, USA, December 1999.
23. Y. Zhuang, V. Holy, J. Stangl, N. Darowski, J. Grenzer, U. Pietsch, S. Zerlauth, F. Schäffler, G. Bauer: “*In-plane strain and shape analysis of Si/SiGe nanostructures by grazing incidence diffraction*”, 6th International Conference on Surface X-ray and Neutron Scattering, Sept. 1999, Nordwijkerhout, Netherlands.
24. T. Roch, J. Stangl, A. Darhuber, G. Bauer, Jian-hong Zhu, K. Brunner, G. Abstreiter: “*Self-organized SiGe quantum dots and wires on vicinal Si(001) substrate correlated laterally by step bunches*”, 4th Autumn School (“X-ray scattering from Surfaces and Thin Layers”), Smolenice, Slowakei, 22.-25. September 1999.
25. A. Daniel, J. Stangl, E. Höflinger, G. Bauer, C. Rosenblad, H. Von Känel: “*Anisotropic Strain Relaxation in Graded SiGe Buffers Grown by Low Energy Plasma Enhanced Chemical Vapor Deposition*”, 4th Autumn School (“X-ray Scattering from Surfaces and Thin Layers”), Smolenice, Slowakei, 22.-25. September 1999.
26. M. Helm, W. Hilber, G. Strasser, R. DeMeester, F. M. Peeters, A. Wacker: “*Interminiband spectroscopy of biased superlattices*”, 5th Int. Conf. on Intersubband Transitions in Quantum Wells, Bad Ischl, Austria, Sept. 1999.
27. M. Helm: “*Infrared spectroscopy of biased superlattices*”, Adriatico Research Conference on “High-Field Transport in Superlattices”, Trieste, Italy, Aug. 1999
28. M. Helm, W. Hilber, G. Strasser, R. DeMeester, F. M. Peeters, A. Wacker: “*Simultaneous investigation of vertical transport and intersubband absorption in a superlattice: continuum Wannier-Stark ladders and next-nearest neighbor tunneling*”, 11th Int. Conf. on Nonequilibrium Carrier Dynamics in Semiconductors (HCIS-11), Kyoto, Japan, July 1999

29. G. Strasser, S. Gianordoli, L. Hvozdar, W. Schrenk, K. Unterrainer, E. Gornik, M. Helm: “*Intersubband and interminiband GaAs/AlGaAs quantum cascade lasers at 10 microns*”, 9th Int. Conf. on Modulated Semiconductor Structures, Fukuoka, Japan, July 1999
30. R. H. J. De Meester, F. M. Peeters, M. Helm: “*Optical absorption of biased semiconductor superlattices*”, 7th Int. Symposium: Nanostructures - Physics and Technology 1999, St. Petersburg, Russia, June 1999
31. M. Helm, W. Hilber, G. Strasser, R. DeMeester, F. M. Peeters: “*Mid-infrared spectroscopy of biased superlattices*”, EUROPTO Conference on THz Spectroscopy and Applications, Munich, BRD, June 1999
32. A.G. Rolo, M.V. Stepikhova, M.I. Vasilevskiy, M.J.M. Gomes, Yu.P. Rakovich, M.V. Artemyev, W. Jantsch, W. Heiss, G. Prechtl: “*Absorption and Photoluminescence Study of CdS Quantum Dots: The Role of Host Matrix and Nanocrystal Size and Density*”, Spring Meeting of the Mat. Res. Soc., San Francisco, USA, April 1999
33. Z. Wilamowski, W. Jantsch, N. Sandersfeld, F. Schäffler: “*Spin Properties of the Two-Dimensional Electron Gas*”, Int. Conf Low Temperature Physics, Helsinki, Finland 1999
34. Z. Wilamowski, W. Jantsch, N. Sandersfeld, F. Schäffler: “*Dipolar Field, Spin Relaxation, e-e Exchange and Spin Gap in Si/SiGe Quantum Wells*”, Int. Conf. On Correlation, Hamburg 1999
35. W. Jantsch, S. Lanzerstorfer, L. Palmetshofer, M. Stepikhova, G. Kocher, H. Preier: “*On the Generation of Optically Active Er Centers in Si Light Emitting Diodes*”, Int. Conf. Defects in Semicond., Berkeley, CA, July 1999
36. W. Jantsch, Z. Wilamowski, N. Sandersfeld, F. Schäffler: “*Determination of Potential Fluctuations in Modulation-Doped SiGe Quantum Wells from Conduction Electron Spin Resonance*”, Int. Conf. Defects in Semicond., Berkeley, CA, July 1999
37. W. Jantsch, Z. Wilamowski, N. Sandersfeld, F. Schäffler: “*Electric and Magnetic Field Fluctuations in Modulation-Doped Si/SiGe Quantum Wells*”, EP2DS-13, Ottawa, Canada, August 1999
38. N. Sandersfeld, W. Jantsch, Z. Wilamowski, F. Schäffler: “*ESR Investigations of Modulation-Doped Si/SiGe Quantum Wells*”, Int. Joint Conf. On Si Epitaxy and Heterostructures, Japan, Sept. 1999
39. M.V. Stepikhova, B.A. Andreev, V.B. Shmagin, Z.F. Krasil'nik, V.P. Kuznetsov, V.G. Shengurov, S.P. Svetlov, W. Jantsch, L. Palmetshofer, F. Schäffler, H. Ellmer: “*Peculiarities and Advantages of Optically Active Si:Er and Si_{1-x}Ge_x Layers Grown by the Sublimation MBE Method*”, Int. Joint Conf. On Si Epitaxy and Heterostructures, Japan, Sept. 1999
40. N. Sandersfeld, W. Jantsch, Z. Wilamowski, F. Schäffler: “*ESR Investigations of Modulation-Doped Si/SiGe Quantum Wells*”, GADEST 99, Höör, Schweden, Sept. 1999

41. T. Schwarzl, W. Heiss, G. Springholz: “*High Finesse Lead Salt Microcavities for the 4-6 μm Spectral Region*”, 3rd Int. Conf. Mid-Infrared Optoelectronics Materials and Devices, Aachen, Sept. 1999
42. W. Heiß, G. Prechtel, D. Stifter, H. Sitter, G. Springholz, T. Riemann, F. Bertram, D. Rudloff, J. Christen, G. Bley, U. Neukirch, J. Gutowski, L. Toth: “*Exciton Dynamics in ZnCdSe/ZnSe Ridge Quantum Wires*”, 9th Int. Conf. Modulated Semicond. Structures, Fukuoka, Japan, July 1999
43. G. Prechtel, W. Heiss, A. Bonanni, S. Mackowski, G. Karczewski, H. Sitter, W. Jantsch: “*Antiferromagnetic Phase Transition in A Single MnTe Monolayer*”, 9th Int. Conf. Modulated Semicond. Structures, Fukuoka, Japan, July 1999
44. T. Schwarzl, W. Heiss, G. Springholz: “*High Finesse Mid Infrared Microcavities Based on Lead Salts*”, 9th Int. Conf. Modulated Semicond. Structures, Fukuoka, Japan, July 1999
45. G. Springholz, T. Schwarzl, W. Heiss, H. Seyringer, S. Lanzerstorfer, H. Krenn: “*Fabrication of Highly Efficient Mid Infrared Bragg Mirrors from IV-VI Semiconductors*”, Aktuelle Entwicklungen der Mikroelektronik, Bad Hofgastein, Austria, March 1999
46. W. Heiss, G. Prechtel, D. Stifter, H. Sitter, G. Springholz, L. Toth: “*ZnCdSe/ZnSe Quantum Wires by Epitaxy on Prepatterned GaAs Substrates*”, Aktuelle Entwicklungen der Mikroelektronik, Bad Hofgastein, Austria, March 1999
47. T. Schwarzl, W. Heiß, G. Kocher-Oberlehner, G. Springholz: “*CH₄/H₂ Plasma Etching of IV-VI Semiconductors*”, Aktuelle Entwicklungen der Mikroelektronik, Bad Hofgastein, Austria, March 1999
48. Bonanni, G. Prechtel, W. Heiß, F. Schinagl, S. Holl, H. Krenn, H. Sitter, D. Stifter, K. Hingerl: “*Reflectance Difference Spectroscopy and Magneto-Optical Analysis of Digital Magnetic Heterostructures*”, 26th Conf. On the Physics and Chemistry of Semicond. Interfaces, San Diego, USA, Jan. 1999
49. H. Sitter, G. Matt, A.Y. Andreev, C.J. Brabec, D. Badt, H. Neugebauer, N.S. Sariciftci: “*Highly Ordered Crystalline Thin Film Bilayers of Para-Hexaphenyl and C60 Grown by Hot Wall Epitaxy*”, MRS Fall Meeting, Boston, Dec. 1999
50. D. Stifter, M. Schmid, K. Hingerl, A. Bonanni, M. Garcia Rocha, H. Sitter: “*In Situ Reflectance Difference Spectroscopy of II-VI Compounds: A Real Time Study of N Plasma Doping During Molecular Beam Epitaxy*”, PCSI-26, San Diego, Jan. 1999
51. Bonanni, K. Hingerl, H. Sitter, D. Stifter: “*Reflectance Difference Spectroscopy of Mn Intra Ion Transitions in p-Doped Diluted Magnetic Semiconductors*”, Int. Conf. Solid State Spectroscopy, Schwäbisch Gmünd, Germany, Sept. 1999
52. Bonanni, H. Sitter, K. Hingerl, D. Stifter: “*Reflectance Difference Spectroscopy of Enhanced Mn Intra Ion Transitions in p-Doped Diluted Magnetic Semiconductors*”, EMRS Spring Meeting, Strasbourg, May 1999
53. G. Neuwirt, K. Hingerl, D. Stifter, A. Bonanni, K. Bierleutgeb, H. Sitter: “*An Algorithm to Determine the Composition and Growth Rate from in-situ Spectral Ellipsometry Data*”, EMRS Spring Meeting, Strasbourg, May 1999

54. W. Hilber, A. Bonanni, H. Sitter, D. Stifter, K. Hingerl: “*Reflectance Difference Spectroscopy: A Powerful Tool for in-situ Investigations of II-VI Surfaces*”, European Conf. Surf. Sci. ECOSS, Vienna, Sept. 1999

Doctor's Theses

1. Dipl.-Ing. Wolfgang Hilber: “Vertikaler Transport, heiße Elektronen und Metall-Isolator Übergang in Halbleiter-Übergittern: elektrische und optische Untersuchungen”, Linz, 1999.
2. Dipl.-Ing. Christian Penn: “Electronic Properties of Si/SiC Heterostructures”, Linz, 1999.
3. Dipl.-Ing. Sven Lanzerstorfer: “Charakterisierung von Er-dotiertem Si”, Linz, 1999.
4. M.Sc. Alberta Bonani: “Growth and Characterization of Semimagnetic Multilayer Structures”, Linz, 1999.

Habilitations

1. Dipl.-Ing. Dr. Gunther Springholz: “Molekularstrahlepitaxie von IV-VI Halbleitern: Wachstumsprozesse und Herstellung von Heterostrukturen”, Linz 1999.

Cooperations

1. Siemens München, Dr.Heide
2. Daimler Benz Reserach Laboratories Ulm, Dr. Presting, Dr. König
3. VOEST ALPINE, Linz, Dr.Angerer,
4. Siemens Villach,
5. AMS Unterpremstätten
6. KEBA, Linz, Ing.G.Krippner
7. Institut für Halbleiterphysik, Frankfurt/Oder
8. Sektion Physik, Ludwig-Maximilians Universität München
9. Physics Department, Cornell University
10. ETH, Zürich
11. ESRF Grenoble
12. DESY, Hasylab, Hamburg
13. FOM Institute Rijnhuizen, Niederlande
14. Walter Schottky Institut, TU München
15. IBM Research Center, Yorktown Heights
16. Institut für Festkörperelektronik, TU Wien
17. Philips Almelo, Niederlande
18. Heriot Watt University, Edinburgh, Scotland

19. University of Southampton, England
20. High Pressure Research Center, Warschau, Polen
21. Institute of Physics, Polish Academy of Sciences, Warschau
22. TU Berlin, Institut für Festkörperphysik
23. Universität Würzburg
24. Universität Bayreuth
25. Universität Bremen
26. Purdue University, Lafayette, IN, USA
27. MIT, Cambridge, MA, USA
28. NIST, Gaithersburg, MD, USA
29. Nanoelectronics Research Center, University of Glasgow, Scotland
30. University of Warwick, Coventry, England
31. North Carolina State University, NC, USA
32. IAF Freiburg
33. CENG Grenoble
34. Universität Paderborn
35. INSA, Lyon
36. Université de Montpellier
37. ELETTRA, Triest
38. Universiteit Instelling, Antwerpen, Niederlande
39. TASC Triest
40. ENEA, Roma
41. CNRSM-PASTIS, Brindisi
42. Akademie der Wissenschaften, Troits, Moskau
43. High Magnetic Field Lab., Grenoble
44. Siemens München, Zentrale Technik, Bereich Halbleiter
45. Fraunhofer-Institut (IAF) Freiburg (Chiptechnologie)
46. TU-München (Mikrowellentechnik)